


<b>Search Notes</b>  	<b>Application/Control No.</b>  10648445	<b>Applicant(s)/Patent Under Reexamination</b>  BEAN ET AL.
	<b>Examiner</b>  USMAN KHAN	<b>Art Unit</b>  2622

SEARCHED			
Class	Subclass	Date	Examiner
348	314,294,296,289,311,314,315,241,248,250,208.1	11/15/2006; 05/07/2007; 08/31/2007; 02/21/2008; 01/02/2008; 06/25/2009	UK
382	225	11/15/2006; 05/07/2007; 08/31/2007; 02/21/2008; 01/02/2008; 06/25/2009	UK

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (Including databases: US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB): See attached EAST search history	11/15/2006; 05/07/2007; 08/31/2007; 02/21/2008; 01/02/2008; 06/25/2009	UK
Inventor name search	11/15/2006; 05/07/2007; 08/31/2007; 02/21/2008; 01/02/2008; 06/25/2009	UK
Subclass 257/431 (text search only - see EAST search history printout)	11/15/2006; 05/07/2007; 08/31/2007; 01/02/2008; 06/25/2009	UK
Examiner: Lin Ye	08/30/2007	UK
Appeal Conference: David Ometz & Lin Ye	12/30/2008	UK

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## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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Examiner.Art Unit 2622